

**Search Notes**

Application/Control No.

10/511,717

Examiner

Son T. Nguyen

Applicant(s)/Patent under  
Reexamination

KEMPSELL ET AL.

Art Unit

3643

**SEARCHED**

Class	Subclass	Date	Examiner
54	44.7 44.1	3/31/2007	STN
	44.3 44.4		
D30	135		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
IPC foreign search, see printouts	3/31/2007	STN
text search, see printouts	3/31/2007	STN